

CHONGQING CLOUDCHILD TECHNOLOGY CO.,LTD

DFN14*12 Plastic-Encapsulate MOSFETS

CCM80N10-6A Full bridge N Channel MOSFET

V _{(BR)DSS}	R _{DS(on)} TYP	I _D
40 V	8.0mΩ@10V	80A

DESCRIPTION

The CCM80N10-6A provides excellent $R_{\text{DS(ON)}}$ with low gate charge. It can be used in a wide variety of applications.

FEATURE

- Split Gate Trench Technology
- Low RDS(ON)
- Low Gate Charge
- Low Gate Resistance
- AEC Q101 qualified

APPLICATION

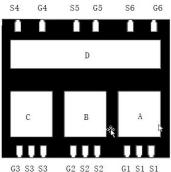
- motor control
- Full bridge module

MARKING

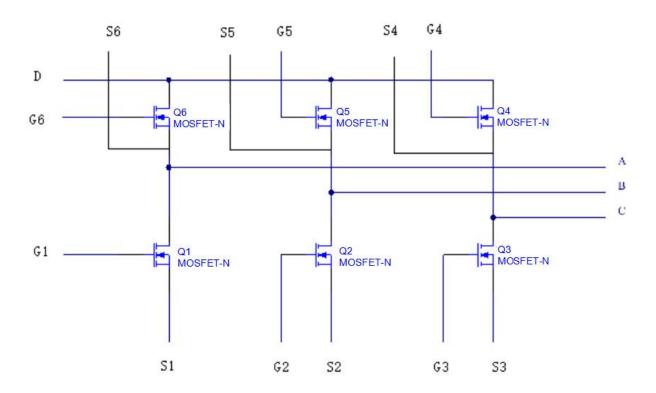


CCM80N10-6A =Part No. XXXXXXX = Code





EQUIVALENT CIRCUIT



Pin Definition

Number	Pin Definition	Remark	Number	Pin Definition	Remark
1	S1	Lower bridge u phase source	11	G4	Upper bridge w gate
2	S1	Lower bridge u phase source	12	S5	Upper Bridge v phase source collection
3	G1	Lower bridge u phase gate	13	G5	Upper bridge v gate
4	S2	Lower bridge v phase source	14	S6	Upper Bridge u phase source collection
5	S2	Lower bridge v phase source	15	G6	Upper bridge u gate
6	G2	Lower bridge v phase gate	PAD 1	D	DC Input
7	S3	Lower bridge w phase source	PAD 2	A	A phase output
8	S3	Lower bridge w phase source	PAD 3	В	B phase output
9	G3	Lower bridge w phase gate	PAD 4	С	C phase output
10	S4	Upper Bridge w phase source collection			

ABSOLUTE MAXIMUM RATINGS (T_a=25C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	100	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current ¹	ID	80	Α
Pulsed Drain Current ²	IDM	320	Α
Single Pulsed Avalanche Energy ³	EAS	240	mJ
Total Power Dissipation	P _D	115	W
Thermal Resistance from Junction to Case ¹	R _{th} JC	1.3	°C/W
Junction Temperature	TJ	175	$^{\circ}$
Storage Temperature	Tstg	-55~+175	$^{\circ}$
Soldering Temperature , for 10S(1.6mm from case)	-	260	$^{\circ}$

Notes:

- 1. Current is limited by package; with a Rthjc = 1.3 $^{\circ}$ C/W the chip is able to carry 85 A at 25 $^{\circ}$ C.
- 2. Pulse Test : Pulse Width $\leq 10\mu s$, duty cycle $\leq 1\%$.
- 3. EAS condition: VDD = 20V,VGS = 10V, L = 0.5mH, RG = 25 Ω , las=31A, Starting TJ = 25 $^{\circ}$ $^{\circ}$ C.

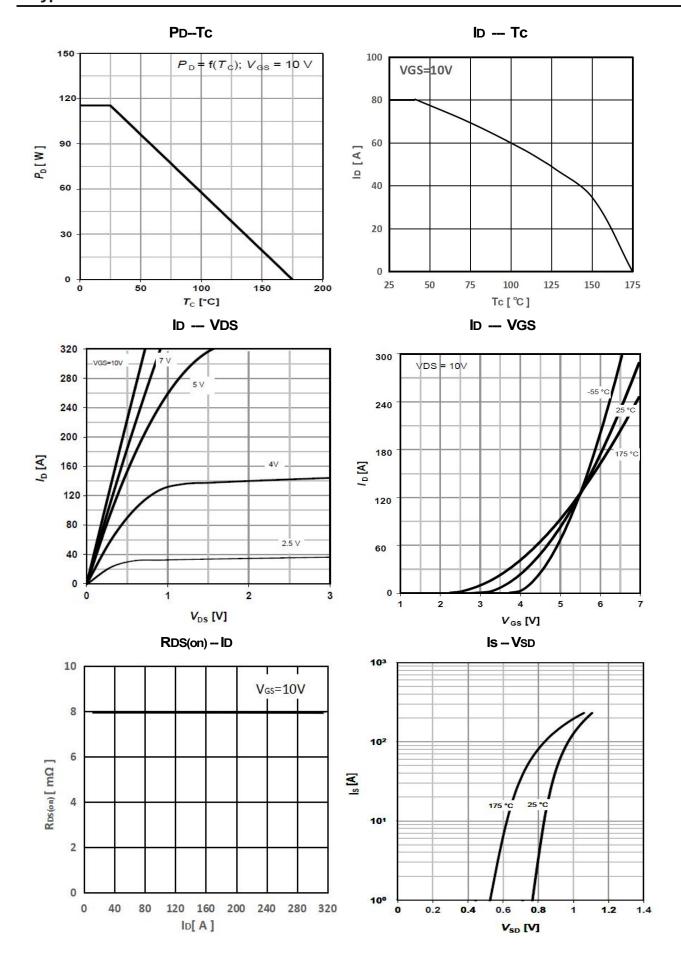
MOSFET ELECTRICAL CHARACTERISTICS

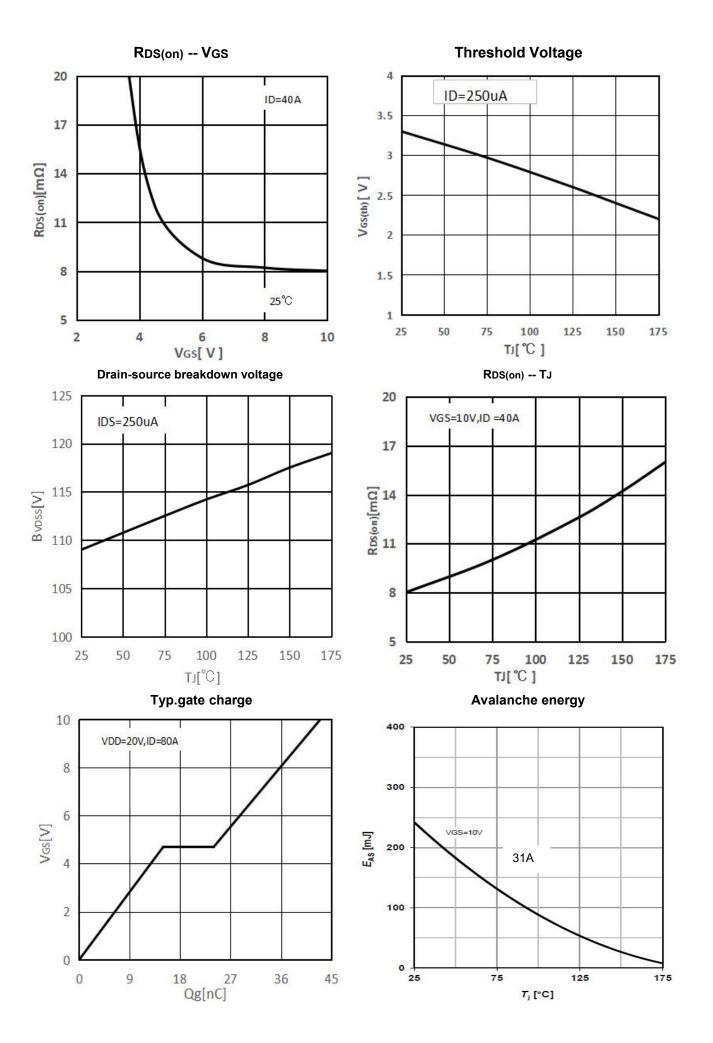
TC=25℃ unless otherwise specified

Parameter	Symbol	Test Condition	Min	Туре	Max	Unit	
Off Characteristics							
Drain - Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	100			V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100V, V _{GS} = 0V			1	μA	
Gate - Body Leakage Current	I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA	
On Characteristics ³							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0	3.3	4.0	V	
Drain-source On-resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 40A		8.0	10	mΩ	
Forward Transconductance	g FS	V _{DS} = 10V, I _D = 40A		65		S	
Dynamic Characteristics							
Input Capacitance	C _{iss}			2183	2850		
Output Capacitance	Coss	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$		1007	1350	pF	
Reverse Transfer Capacitance	Crss			89	120		
Gate Resistance	Rg	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$		2.1		Ω	
Switching Characteristics			•				
Total Gate Charge	Qg			43			
Gate-source Charge	Q_{gs}	$V_{DD} = 20V, V_{GS} = 10V, I_D = 80A$		15		nC	
Gate-drain Charge	Q_{gd}			9			
Turn-on Delay Time	t _{d(on)}			18			
Turn-on Rise Time	t _r	$V_{DD} = 20V, V_{GS} = 10V, R_L = 1\Omega$,		42		ns	
Turn-off Delay Ttime	$t_{d(off)}$	$R_G = 3\Omega$		31			
Turn-off Fall Time	t _f			8			
Source - Drain Diode Characteristics							
Diode Forward Voltage ³	V _{SD}	V _{GS} = 0V, I _S = 80A			1.2	V	
Continuous drain-source diode forward		_			90	A	
Current ¹	ls				80		
Pulsed drain-source diode forward current ²	I _{SM}	-			320	A	
Reverse recovery time	Trr	Vr=50V ,Ir=80A,dI/dt=100A/us		71		ns	
Reverse recovery charge	Qrr	551 ; 551 ;; dirac 1557 yd5		123		nC	

Notes:

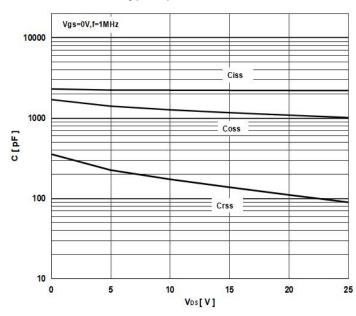
- 1. Current is limited by package; with a Rthjc = 1.3 $^{\circ}$ C/W the chip is able to carry 85 A at 25 $^{\circ}$ C.
- 2. P_W≤10µs, Duty cycle≤1%.
- 3. Pulse Test : Pulse Width $\leq 300\mu s$, duty cycle $\leq 2\%$.

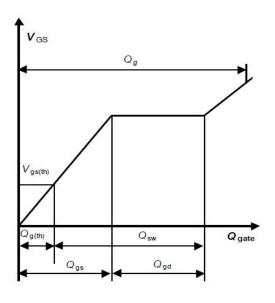




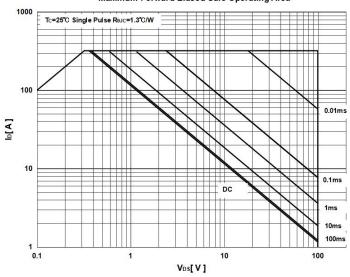
Typ. capacitances

Gate charge waveforms

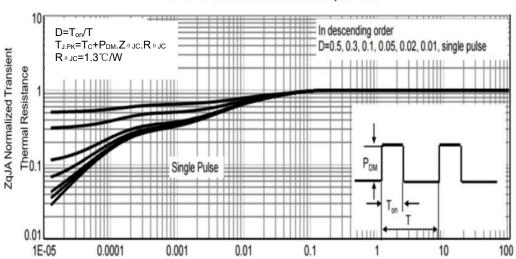




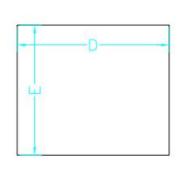
Maximum Forward Biased Safe Operating Area

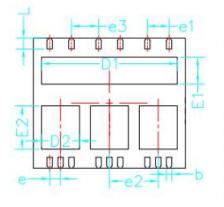


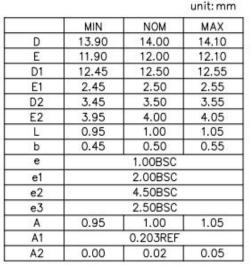
Normalized Thermal Transient Impedance



DFN14*12 Package Outline Dimensions

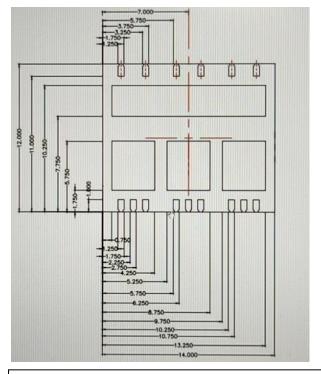








DFN14*12 Suggested Pad Layout



Note:

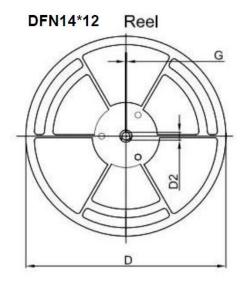
- 1. Controlling dimension: in millimeters.
- 2. General tolerance:0.5mm.
- 3. The pad layout is for reference purposes only.

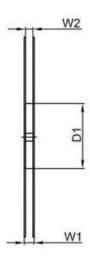
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DFN14*12 Tape and Reel





			Dimensio	ns are in millime	ter	
Reel Option	D	D1	D2	G	W1	W2
13"Dla	Ø330.00	100,00	13.00	1.90	28.40	24.00

REEL	Reel Size	Box	Box Size(mm)	Carton	Carton Size(mm)
2,000 pcs	13 inch	4,000 pcs	340×336×29	20,000 pcs	353×346×365

Rev#	revise content
A/0	/